

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Patent Application Serial No. 09/730,335
Filing Date 12/04/2000
Inventorship Charles H. Dennison
Assignee Micron Technology, Inc.
Group Art Unit 2811
Examiner Ori Nadav
Attorney's Docket No. MI22-1577
Title Field Effect Transistors and Integrated Circuitry

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

References - See Attached Form PTO-1449

In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the United States patents and other references listed on the attached Form PTO-1449. A copy of the cited art is attached hereto. No admission is made regarding whether the submitted reference is prior art.

This Supplemental Information Disclosure Statement is being filed before the mailing of a first office action after the filing of a request for continued examination. Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. § 1.17(p) to Deposit Account No. 23-0925.

Respectfully submitted,

Dated: 3-29-04

By: 
Mark S. Matkin
Reg. No. 32,268

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-1577		SERIAL NO. 09/730,335	
<div style="position: relative; height: 100px;"> <div style="position: absolute; top: 0; left: 0; width: 100%; text-align: center;"> LIST OF ART CITED BY APPLICANT <small>(Use several sheets if necessary)</small> </div> <div style="position: absolute; top: 50%; left: 50%; transform: translate(-50%, -50%); font-size: 2em; font-weight: bold;"> OFFICE MAR 29 2004 PATENT & TRADEMARK OFFICE </div> </div>				APPLICANT: Charles H. Dennison			
				FILING DATE December 4, 2000		GROUP 2811	
U.S. PATENT DOCUMENTS							
*Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA	6,537,909	03/2003	Lin et al.	438	653	
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation Yes No
	AI						
	AJ						
	AK						
	AL						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
	AM						
	AN						
	AO						
EXAMINER		DATE CONSIDERED					
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EL 979951614

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Customer No. 021567
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COPY

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

References -- See Attached Form PTO-1449

The attached form PTO-1449 is submitted in compliance with 37 CFR §1.56. Copies of the cited prior art references are attached. No admission is made regarding whether all the listed references are prior art.

Respectfully submitted,

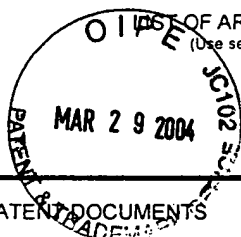
Dated: 2-20-04

By: 

Mark S. Matkin
Reg. No. 32,268

EV 372452480

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U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
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09/730,335OFFICE OF ART CITED BY APPLICANT
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APPLICANT: Charles H. Dennison

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2811

U.S. PATENT DOCUMENTS

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	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						

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FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AI	64-042857	02/15/89	Japan (Toshio)			Abstract	
	AJ	64-072543	03/17/89	Japan (Koji et al.)			Abstract	
	AK	03-192768	08/22/91	Japan (Masae)			Abstract	
	AL	06-204171	07/22/94	Japan (Mamoru)			X	

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

	AM		
	AN		
	AO		
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